

HI-546/883 HI-547/883

Single 16/Differential 8 Channel CMOS Analog Multiplexers With Active Overvoltage Protection

January 1989

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- This Circuit is Processed in Accordance to Mil-Std-883 and is Fully Conformant Under the Provisions of Paragraph 1.2.1.
- No Channel Interaction During Overvoltage
- Guaranteed Ron Matching
- 44V Maximum Power Supply
- . Break-Before-Make Switching
- Analog Signal Range.....±15V
- Access Time (Max.)1.0µs
- Power Dissipation (Max.)45mW

Applications

- Data Acquisition Systems
- Control Systems
- Telemetry

Description

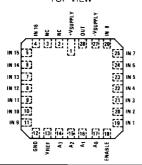
The HI-546/883 and HI-547/883 are analog multiplexers with Active Overvoltage Protection and guaranteed RON matching. Analog input levels may greatly exceed either power supply without damaging the device or disturbing the signal path of other channels. Active protection circuitry assures that signal fidelity is maintained even under fault conditions that would destroy other multiplexers. Analog inputs can withstand constant 70 volt peak-topeak levels with ±15V supplies and digital inputs will sustain continuous faults up to 4 volts greater than either supply. In addition, signal sources are protected from short circuiting should multiplexer supply loss occur; each input presents 1kΩ of resistance under this condition. These features make the Hi-546/883 and HI-547/883 ideal for use in systems where the analog inputs originate from external equipment or separately powered circuitry. Both devices are fabricated with 44 volt dielectrically isolated CMOS technology. The HI-546/883 is a 16 channel device and the HI-547/883 is an 8 channel differential version. If input overvoltage protection is not needed, the HI-506/883 and HI-507/883 multiplexers are recommended. For further information see Application Notes 520 and 521

Pinouts

HI1-546/883 (CERAMIC DIP) TOP VIEW

+VSUPPLY [, ,	28	D OUT
NC C	2	27	-VSUPPLY
NC C	3	26	D IN 8
IN 16	4	25	D IN 7
IN 15 🖺	5	24	D IN 6
₹N 14 🗀	6	23	D IN 5
IN 13 🗆	7	22	□ IN 4
IN 12 C	8	21	IN 3
IN 11 🗆	9	20	D IN 2
IN 10 🗆	10	19	ו או 🗖
IN 9 🗆	11	18	ENABLE
GND [12	17	ADDRESS AO
VREF C	13	16	ADDRESS A1
ADDRESS A3 [14	15	ADDRESS A2

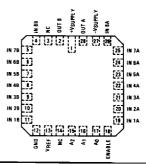
HI4-546/883 (CERAMIC LCC) TOP VIEW



HI1-547/883 (CERAMIC DIP) TOP VIEW

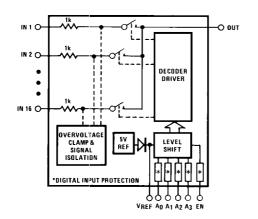
+VSUPPLY [28 DOUT A OUT B 27 -VSUPPLY NC [3 26 D IN 8A IN 8B 4 25 | IN 7A IN 78 🗆 5 24 D IN 6A IN 68 6 23 D IN 5A IN 5B 🗆 7 22 D IN 4A IN 4B 28 21 | IN 3A 20 | IN 2A IN 3B [9 19 1 IN 1A 18 1 ENABLE IN 2B C 10 IN 18 🗖 11 GND 🗆 12 17 D ADDRESS An VREF 13 16 ADDRESS AT 15 ADDRESS AZ NC 14

HI4-547/883 (CERAMIC LCC) TOP VIEW



Functional Diagrams

HI-546/883

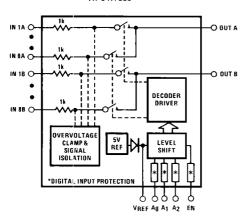


TRUTH TABLES

HI-546/883

A ₃	A ₂	A ₁	A ₀	EN	"ON" CHANNEL
Х	Х	Х	Х	L	None
L	LLLH	L	L	н	1
L	L	L	н	н	2
L	L	Н	H H L	Н	2 3 4 5
L	L	Н	н	н	4
L	Н	L	L	н	5
L	Н	L	н	н	6
XLLLLLLHH	Н	н	HL	*******	7
L	Н	н	н	н	8
Н	L	L	L	н	9
н	L	L	н	н	10
Н	L	н	L	н	11
H	L	н	н	н	12
н	HLLLLH	L	HL	н	13
Н	Н				14
H	H	н	H L H	н	15
Н	Н	н	н	н	16

HI-547/883



HI-547/883

A ₂	A ₁	A ₀	EN	"ON" CHANNEL PAIR
Х	Х	х	L	None
L	L	L	H	1
L	L	н	н	2
L	н	L	H	3
L	н	н	H	4
н	L	L	H	5
Н	L	н	Н	6
н	Н	L	H	7
н	Н	н	н	8

Specifications HI-546/883 HI-547/883

	Junction Temperature	+175°C
Oltage Between Supply Pins 44V VSUPPLY to Ground 22V	Thermal Resistance, Junction-to-Case (θjc)	
VSUPPLY to Ground	Ceramic DIP Package1	8°C/W
nalog input Voltage	Ceramic LCC Package4	
+V _S +V _{SUPPLY} +20V	Thermal Resistance, Junction-to-Ambient (6ja)	
-VSVSUPPLY -20V	Ceramic DIP Package5	50°C/W
Digital Input Voltage	Geramic LCC Package	
+V _{EN} , +V _A +V _{SUPPLY} +4V	Power Dissipation	
-VEN, -VAVSUPPLY -4V	Ceramic DIP Package	2.0V
or 20mA, whichever occurs first.	Ceramic LCC Package	1.23V
Continuous Current, S or D20mA	Power Dissipation Derating Factor (Above +75°C)	
eak Current, S or D	Ceramic DIP Package20.0	
(Pulsed at 1ms, 10% Duty Cycle Max.)40mA	Ceramic LCC Package12.3	mW/OC
storage Temperature Range65°C to +150°C ead Temperature (Soldering 10 Seconds)275°C	ESD Classification	≤2000\
Recommended Operating Conditions		
Operating Temperature Range55°C to +125°C		to 0.8
Operating Supply Voltage (±VSUPPLY)±15V	Logic High Level (V _{AH})+4V to +V _S Max RMS Current, S or D	

TABLE 1. D.C. ELECTRICAL PERFORMANCE CHARACTERISTICS

Devices Tested at +VSUPPLY = +15V, -VSUPPLY = -15V, VEN = 4.0V, VREF (Pin 13) = OPEN, Unless Otherwise Specified.

			GROUP A		LIM		
D.C. PARAMETERS	SYMBOL	CONDITIONS	SUBGROUPS	TEMPERATURE	MIN	MAX	UNITS
Input Leakage Current	lін	Measure Inputs Sequentially,	1, 2, 3	+25°C, +125°C, -55°C	-1.0	1.0	μA
	1 _{IL}	Connect All Unused Inputs to GND	1, 2, 3	+25°C, +125°C, -55°C	-1.0	1.0	μА
Leakage Current Into	+IS(OFF)	V _S = +10V, V _D = -10V, V _{EN} = 0.8V	1	+25°C	-10	+10	nA
the Source Terminal of		All Unused Inputs = -10V	2, 3	+125°C, -55°C	-50	+50	. nA
an"OFF" Switch	^{-I} S(OFF)	$V_S = -10V$, $V_D = +10V$, $V_{EN} = 0.8V$	1	+25°C	-10	+10	nA
		All Unused Inputs = +10V	2, 3	+125°C, -55°C	-50	+50	nA
Leakage Current Into	*ID(OFF)	V _D = +10V, V _{EN} = 0.8V	i	+25°C	-10	+10	nA
the Drain Terminal of		All Unused Inputs = -10V HI-546/883	2, 3	+125°C, -55°C	-300	+300	nA
an "OFF" Switch		HI-547/883	2, 3	+25°C, -55°C	-200	+200	nA
	-ID(OFF)	V _D = -10V, V _{EN} = 0.8V	1	+25 ⁰ C	-10	+10	nA
		All Unused Inputs = +10V HI-546/883	2, 3	+25°C, -55°C	-300	+300	пА
		HI-547/883	2, 3	+125°C, -55°C	-200	+200	nА
Leakage Current From	*ID(ON)	V _{IN} (Selected Chan.) = V _D = +10V	1	+25°C	~10	+10	nΑ
an "ON" Driver Into		V_S = Unused Inputs = -10V H1-546/883	2, 3	+125°C, -55°C	-300	+300	nΑ
the Switch (Drain)		HI-547/883	2, 3	+125°C, -55°C	-200	+200	nA
	-ID(ON)	V _{IN} (Selected Chan.) = V _D = -10V	1	+25°C	-10	+10	nA
		V _S = Unused Inputs = +10V HI-546/883	2, 3	+125°C, -55°C	-300	+300	nA
		HI-547/883	2, 3	+125°C, -55°C	-200	+200	nΑ
Overvoltage Protected,	I _D (OFF)	$V_S = 33V$, $V_D = 0V$, $V_{EN} = 0.8V$	1, 2, 3	+25°C, +125°C, -55°C	-2.0	+2.0	μΑ
Leakage Current Into	Overvoltage	V _S applied at ≤ 25% duty cycle					
the Drain Terminal of		$V_S = -33V$. $V_D = 0V$, $V_{EN} = 0.8V$	1, 2, 3	+25°C, +125°C, -55°C	-2.0	+2.0	μΑ
an "OFF" Switch		V _S applied at ≤ 25% duty cycle		L			
Positive Supply Current	İ(+)	V _A = 0V, V _{EN} = 4.0V	1, 2, 3	+25°C, +125°C, -55°C		2.0	mA
Negative Supply Current	1(-)	V _A = 0V, V _{EN} = 4.0V	1, 2, 3	+25°C, +125°C, -55°C	-1.0		mA
Standby Positive Supply Current	*ISBY	V _A = 0V, V _{EN} = 0V	1, 2, 3	+25°C, +125°C, -55°C		2.0	mA
Standby Negative Supply Current	-ISBY	V _A = 0V, V _{EN} = 0V	1, 2, 3	+25°C, +125°C, -55°C	-1.0		mA
Switch "ON"	+R _{DS1}	V _S = 10V	1	+25°C		1500	Ω
Resistance		I _D = 100μA	2, 3	+125°C, -55°C		1800	Ω
	-R _{DS1}	V _S = -10V	1	+25°C		1500	Ω
	50'	I _D = -100 <i>μ</i> A	2, 3	+125°C, -55°C		1800	Ω
Logic Level Voltage	V _{AL1}	Notes 1, 2	1, 2, 3	+25°C, +125°C, -55°C		0.8	٧
_ 3-	V _{AH1}	Notes 1, 2	1, 2, 3	+25°C, +125°C, -55°C	4.0		V
	V _{AL2}	Note 3	1, 2, 3	+25°C, +125°C, -55°C		0.8	V
	V _{AH2}	Note 3	1, 2, 3	+25°C, +125°C, -55°C	6.0	İ	V
Difference in switch "ON" Resistance	+ΔR _{DS1}	(+R _{DS1} MAX) - (+R _{DS1} MIN) x 100 +R _{DS1} AVE	1	+25°C		7	%
Between Channels	-ΔR _{DS1}	(-R _{DS1} MAX) - (-R _{DS1} MIN) x 100 -R _{DS1} AVE	1	+25°C		7	%

TABLE 2. A.C. ELECTRICAL PERFORMANCE CHARACTERISTICS

Devices Tested at +VSUPPLY = +15V, -VSUPPLY = -15V, VEN = 4.0V, VREF (Pin 13) = OPEN, Unless Otherwise Specified.

					LIMITS		
A.C. PARAMETER	SYMBOL	CONDITIONS	SUBGROUP	TEMP	MIN	MAX	UNITS
Break-Before-Make Time Delay	tD	A _L = 1kΩ, C _L = 12.5pF	9	+25°C	25		ns
Propagation Delay	t _A	R _L = 10MΩ, C _L = 14pF	9	+25°C		500	пѕ
Times: Address Inputs to I/O Channel Times			10, 11	+125°C, -55°C		1000	ns
Enable to I/O	tON(EN)	R _L = 1kΩ, C _L = 12.5pF	9	+25°C		500	ns
			10, 11	+125°C, -55°C		1000	ns
	tOFF(EN)	R _L = 1kΩ, C _L = 12.5pF	9	+25°C		500	ns
			10, 11	+125°C, -55°C		1000	ns

TABLE 3. ELECTRICAL PERFORMANCE CHARACTERISTICS

Characterized at +VSUPPLY = +15V, -VSUPPLY = -15V, VEN = 4.0V, VREF (Pin 13) = OPEN, Unless Otherwise Specified.

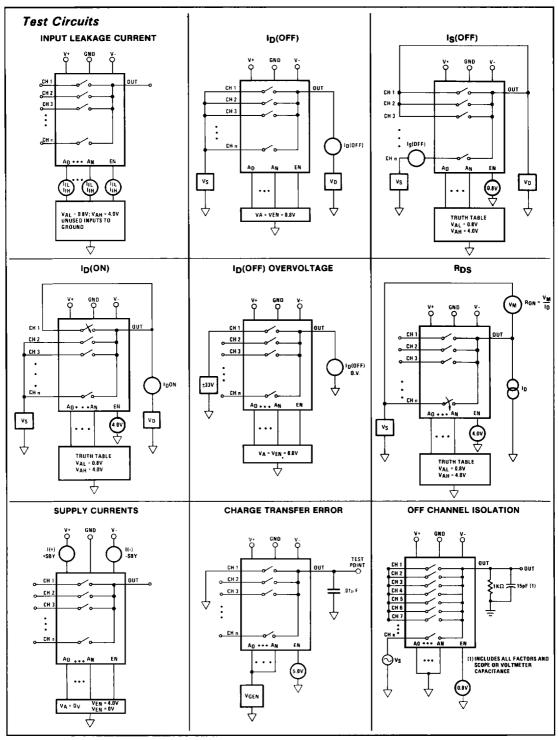
					LIM	ITS	
PARAMETER	SYMBOL	CONDITIONS	NOTE	TEMP	MIN	MAX	UNITS
Capacitance: Address Input	CA	V+ = V- = 0V f = 1MHz	4	+25°C		12	pF
Capacitance:	cos	V+ = V- = 0V H1-546/883	4	+25°C		85	pF
Output Switch		f = 1MHz HI-547/883	4	+25°C		50	pF
Capacitance Input Switch	CIS	V+ = V- + 0V f = 1MHz	4	+25°C		15	pF
Charge Transfer Error	VCTE	V _S = GND VGEN = 0V to 5V	4	+25°C		10	m∨
Off Isolation	V _{ISO}	V_{EN} = 0.8V, R_L = 1k Ω C_L = 15pF, V_S = 7VRMS f = 100kHz	4, 5	+25°C	-50		dΒ

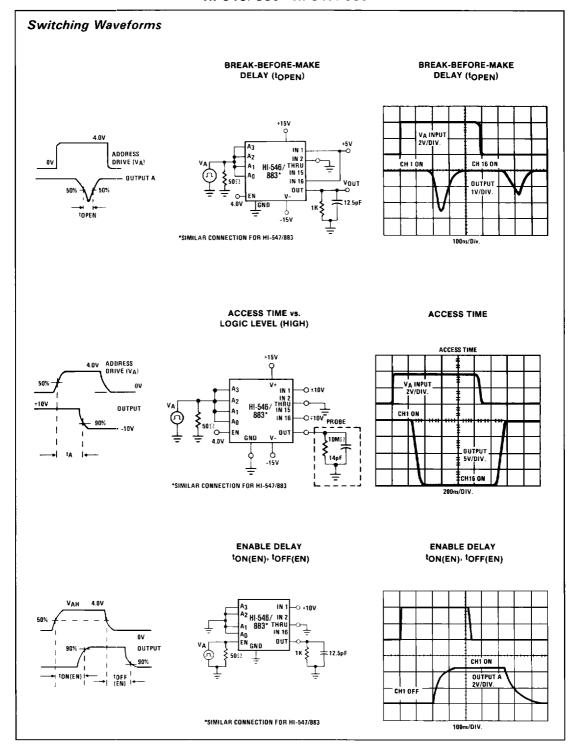
- NOTES: 1. Used for forcing conditions for all DC Tests, unless otherwise specified.
 - 2. To drive from DTL/TTL circuits, 1kΩ pull-up resistors to +5.0V supply are recommended.
 - 3. V_{REF} = +10V.
 - 4. The parameters listed in this table are controlled via design or process parameters and are not directly tested. These parameters are characterized upon initial design release and upon design changes which would affect these characteristics.
 - 5. Worst case isolation occurs on channel 8B due to proximity of the output pins.

TABLE 4. ELECTRICAL TEST REQUIREMENTS

MIL-STD-883 TEST REQUIREMENTS	SUBGROUPS (SEE TABLES 1, 2 & 3)
Interim Electrical Parameters (Pre Burn-In)	1
Final Electrical Test Parameters	1*, 2, 3, 9, 10, 11
Group A Test Requirements	1, 2, 3, 9, 10, 11
Groups C & D Endpoints	1

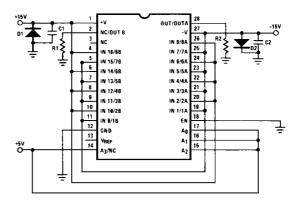
^{*}PDA applies to Subgroup 1 only. No other subgroups are included in PDA.





Burn-In Circuits

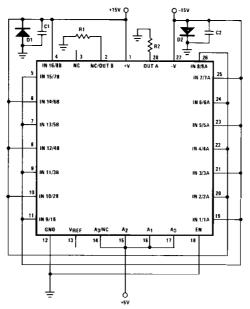
HI-546/883 HI-547/883 CERAMIC DIP



R1, R2 = $10k\Omega \pm 5\%$ 1/2 or 1/4W (per socket)

C1, C2 = 0.01 µF (per socket) or 0.1 µF (per row)
D1, D2 = IN4002 (or equivalent) (per board)

HI-546/883 HI-547/883 **CERAMIC LCC**

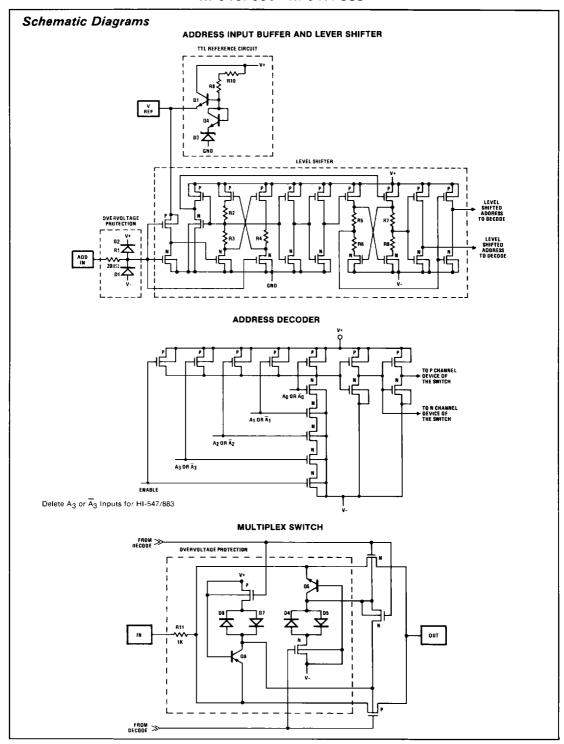


NOTES:

R1, R2 = $10k\Omega \pm 5\%$ 1/2 or 1/4W (per socket)

C1, C2 = $0.01\mu F$ (per socket) or $0.1\mu F$ (per row)

D1, D2 = IN4002 (or equivalent) (per board)



Die Characteristics

DIE DIMENSIONS: 83.9 x 159 x 19 mils **METALLIZATION**

Type: Al

Thickness: 16kÅ ± 2kÅ

GLASSIVATION

Type: Nitride

Thickness: 7kÅ ± 0.7kÅ

WORST CASE CURRENT DENSITY: 1.4 x 10⁵ A/cm²

TRANSISTOR COUNT:

HI-546/883 485

HI-547/883 485 **PROCESS:** CMOS-DI

DIE ATTACH

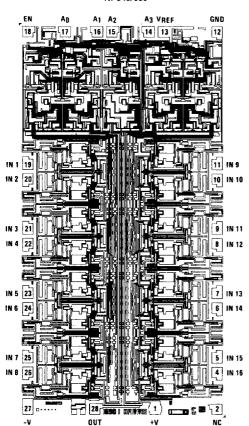
Material: Gold Silicon Eutectic Alloy

Temperature: Ceramic DIP — 460°C (Max)

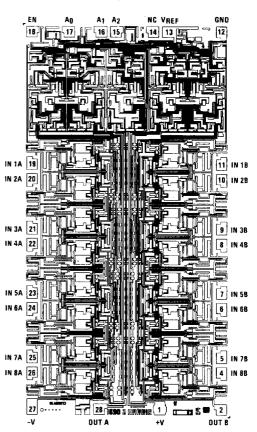
Ceramic LCC — 420°C (Max)

Metallization Mask Layout

HI-546/883

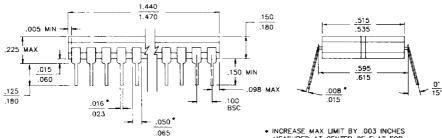


HI-547/883



Packaging †

28 PIN CERAMIC DIP



* INCREASE MAX LIMIT BY .003 INCHES MEASURED AT CENTER OF FLAT FOR SOLDER FINISH

LEAD MATERIAL: Type B LEAD FINISH: Type A

PACKAGE MATERIAL: Ceramic, 90% Alumina

PACKAGE SEAL:

Material: Glass Frit Temperature: 450°C ± 10°C

Method: Furnace Seal

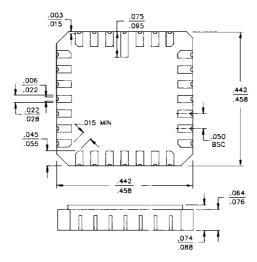
INTERNAL LEAD WIRE:

Material: Aluminum Diameter: 1.25 Mil

Bonding Method: Ultrasonic

COMPLIANT OUTLINE: 38510 D-10

28 PAD CERAMIC LCC



PAD MATERIAL: Type C PAD FINISH: Type A FINISH DIMENSION: Type A

PACKAGE MATERIAL: Multilayer Ceramic, 90% Alumina

PACKAGE SEAL:

Material: Gold/Tin (80/20) Temperature: 320°C ± 10°C Method: Furnace Braze

INTERNAL LEAD WIRE:

Material: Aluminum Diameter: 1.25 Mil

Bonding Method: Ultrasonic COMPLIANT OUTLINE: 38510 C-4



DESIGN INFORMATION

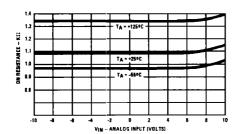
HI-546 HI-547

Single 16/Differential 8 Channel CMOS Analog Multiplexers With Active Overvoltage Protection

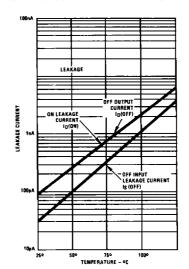
The information contained in this section has been developed through characterization by Harris Semiconductor and is for use as application and design data only. No guarantee is implied.

Typical Performance Characteristics Unless Otherwise Specified: T_A = 25°C, V_{SUPPLY} = ±15V,
V_{AH} = +4V, V_{AL} = 0.8V, V_{RFF} = Open

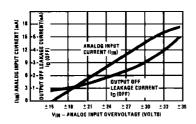
ON RESISTANCE VS. ANALOG INPUT VOLTAGE



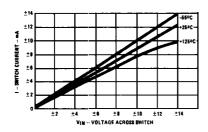
LEAKAGE CURRENT vs. TEMPERATURE



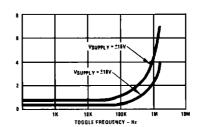
ANALOG INPUT OVERVOLTAGE CHARACTERISTICS



ON CHANNEL CURRENT vs. VOLTAGE



SUPPLY CURRENT VS. TOGGLE FREQUENCY



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FSA9591UCX FSSD07BQX MAX7356ETG NLV74HCT4851ADRG 7705201EC MAX4634ETBT MAX4578CAP+ PI2SSD3212NCE

MAX3997ETM+ NLV14052BDTR2G PI3L100QE PI3DBS12412AZLEX PI3V512QEX MAX4969CTO+ PI3DBS12212AZBEX

PI3DBS16415ZHEX MAX7367EUP+T MAX7369EUP+ MAX7357ETG+T NLV74HC4053ADR2G NLVAST4051DTR2G

PI3DBS12412AZHEX ADG5209BCPZ-RL7 PS509WEX PS509QEX PS508QEX PS508WEX ADG5209FBRUZ-RL7 ADG5208FBRUZ-RL7 MAX14984ETG+ MAX14984ETG+T HV2818/R4X HV2918/R4X CBTU02044HEJ PS508LEX PS509LEX